#### DATA SHEET



# MOS FIELD EFFECT TRANSISTOR NP83P06PDG

# SWITCHING P-CHANNEL POWER MOSFET

#### **DESCRIPTION**

The NP83P06PDG is P-channel MOS Field Effect Transistor designed for high current switching applications.

#### <R> ORDERING INFORMATION

| PART NUMBER           | LEAD PLATING  | PACKING         | PACKAGE          |  |  |
|-----------------------|---------------|-----------------|------------------|--|--|
| NP83P06PDG-E1-AY Note |               | Tara 000 alasal | TO 000 (MD 057D) |  |  |
| NP83P06PDG-E2-AY Note | Pure Sn (Tin) | Tape 800 p/reel | TO-263 (MP-25ZP) |  |  |

Note Pb-free (This product does not contain Pb in external electrode.)

#### **FEATURES**

• Super low on-state resistance

 $R_{DS(on)1} = 8.8 \text{ m}\Omega \text{ MAX.}$  (Vgs = -10 V, ID = -41.5 A)

 $R_{DS(on)2} = 12 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -4.5 \text{ V, I}_D = -41.5 \text{ A})$ 

• High current rating: I<sub>D(DC)</sub> = ∓83 A

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (VGS = 0 V)             | VDSS                  | -60         | V  |
|---|-----------------------|-------------|----|
| Gate to Source Voltage (VDS = 0 V)              | Vgss                  | ∓20         | V  |
| Drain Current (DC) (Tc = 25°C)                  | I <sub>D(DC)</sub>    | ∓83         | Α  |
| Drain Current (pulse) Note1                     | I <sub>D(pulse)</sub> | ∓249        | Α  |
| Total Power Dissipation (Tc = 25°C)             | P <sub>T1</sub>       | 150         | W  |
| Total Power Dissipation (T <sub>A</sub> = 25°C) | P <sub>T2</sub>       | 1.8         | W  |
| Channel Temperature                             | Tch                   | 175         | °C |
| Storage Temperature                             | Tstg                  | -55 to +175 | °C |
| Single Avalanche Current Note2                  | las                   | 49          | Α  |
| Single Avalanche Energy Note2                   | Eas                   | 240         | mJ |

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

2. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = -30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> =  $-20 \rightarrow 0$  V

#### THERMAL RESISTANCE

| Channel to Case Thermal Resistance    | Rth(ch-C) | 1.0  | °C/W |  |
|---------------------------------------|-----------|------|------|--|
| Channel to Ambient Thermal Resistance | Rth(ch-A) | 83.3 | °C/W |  |

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(TO-263)



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#### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

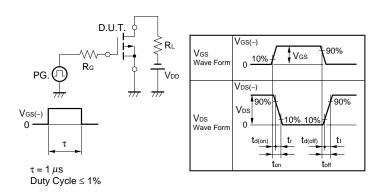
| CHARACTERISTICS                          | SYMBOL               | TEST CONDITIONS                                    | MIN. | TYP.  | MAX. | UNIT |
|--|----------------------|--|------|-------|------|------|
| Zero Gate Voltage Drain Current          | Ioss                 | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V     |      |       | -10  | μΑ   |
| Gate Leakage Current                     | Igss                 | V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V     |      |       | ∓100 | nA   |
| Gate to Source Threshold Voltage         | V <sub>GS(th)</sub>  | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA    | -1.0 | -1.6  | -2.5 | V    |
| Forward Transfer Admittance Note         | <b>y</b> fs          | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -41.5 A  | 30   | 60    |      | S    |
| Drain to Source On-state Resistance Note | R <sub>DS(on)1</sub> | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -41.5 A  |      | 6.9   | 8.8  | mΩ   |
|  | R <sub>DS(on)2</sub> | V <sub>GS</sub> = −4.5 V, I <sub>D</sub> = −41.5 A |      | 8.0   | 12   | mΩ   |
| Input Capacitance                        | Ciss                 | V <sub>DS</sub> = -10 V,                           |      | 10100 |      | pF   |
| Output Capacitance                       | Coss                 | V <sub>GS</sub> = 0 V,                             |      | 1140  |      | pF   |
| Reverse Transfer Capacitance             | Crss                 | f = 1 MHz  |      | 660   |      | pF   |
| Turn-on Delay Time                       | t <sub>d(on)</sub>   | V <sub>DD</sub> = -30 V, I <sub>D</sub> = -41.5 A, |      | 36    |      | ns   |
| Rise Time                                | tr                   | V <sub>GS</sub> = -10 V,                           |      | 20    |      | ns   |
| Turn-off Delay Time                      | t <sub>d(off)</sub>  | R <sub>G</sub> = 0 Ω                               |      | 230   |      | ns   |
| Fall Time                                | tf                   |  |      | 200   |      | ns   |
| Total Gate Charge                        | Q <sub>G</sub>       | V <sub>DD</sub> = -48 V,                           |      | 190   |      | nC   |
| Gate to Source Charge                    | Q <sub>G</sub> s     | V <sub>GS</sub> = -10 V,                           |      | 20    |      | nC   |
| Gate to Drain Charge                     | Q <sub>GD</sub>      | I <sub>D</sub> = -83 A                             |      | 53    |      | nC   |
| Body Diode Forward Voltage Note          | V <sub>F(S-D)</sub>  | I <sub>F</sub> = -83 A, V <sub>GS</sub> = 0 V      |      | 0.94  | 1.5  | V    |
| Reverse Recovery Time                    | trr                  | I <sub>F</sub> = -83 A, V <sub>GS</sub> = 0 V,     |      | 63    |      | ns   |
| Reverse Recovery Charge                  | Qrr                  | di/dt = –100 A/ <i>μ</i> s                         |      | 101   |      | nC   |

**Note** Pulsed test PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2%

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $V_{GS} = -20 \rightarrow 0 \text{ V}$ $V_{DD}$ $V_{DD}$

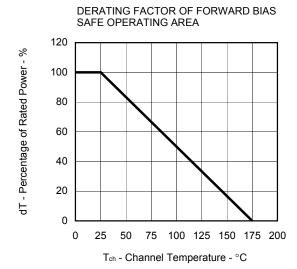
#### TEST CIRCUIT 2 SWITCHING TIME

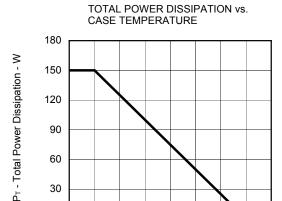


#### **TEST CIRCUIT 3 GATE CHARGE**

$$\begin{array}{c|c} D.U.T. \\ \hline \\ IG = -2 \text{ mA} \\ \hline \\ PG. \\ \hline \\ \end{array} \begin{array}{c} RL \\ \hline \\ V_{DD} \\ \hline \end{array}$$

#### TYPICAL CHARACTERISTICS (TA = 25°C)





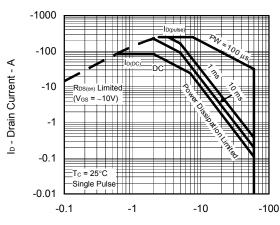
0

0 25 50

Tc - Case Temperature - °C

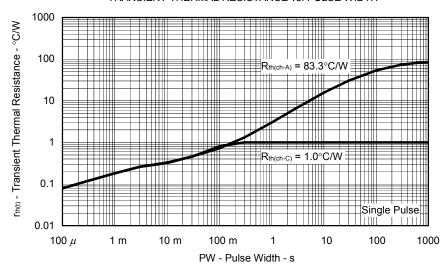
100 125 150 175 200

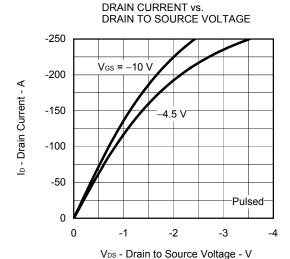
#### FORWARD BIAS SAFE OPERATING AREA



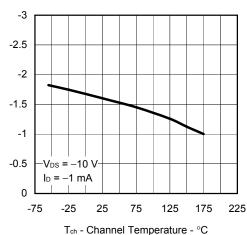
 $V_{\text{\scriptsize DS}}$  - Drain to Source Voltage - V

#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

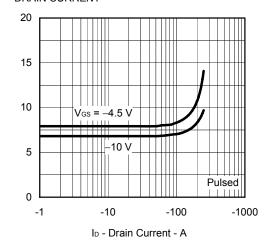




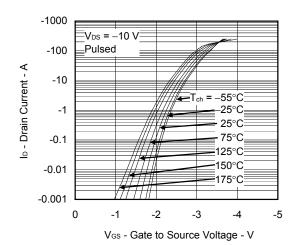




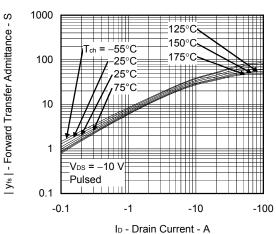
## DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



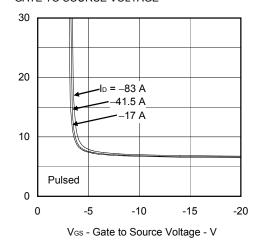
#### FORWARD TRANSFER CHARACTERISTICS



### FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



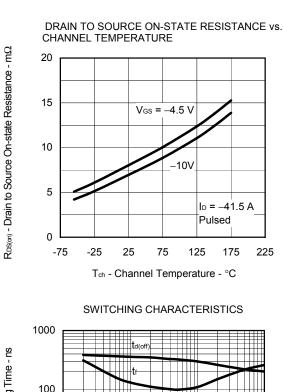
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

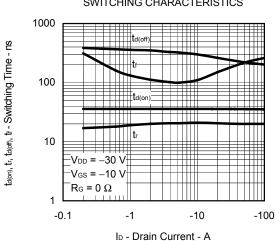


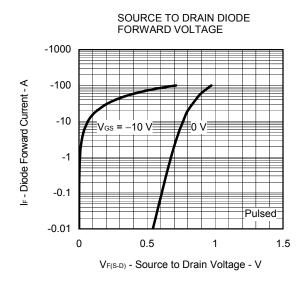
 $\mathsf{Res}_{(\mathsf{on})}$  - Drain to Source On-state Resistance -  $m\Omega$ 

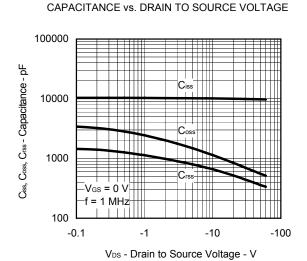
Vos(th) - Gate to Source Threshold Voltage - V

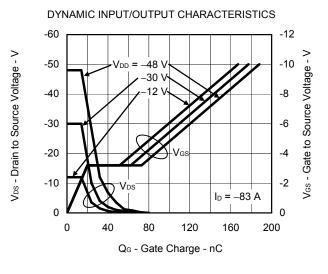
RDS(ση) - Drain to Source On-state Resistance - mΩ

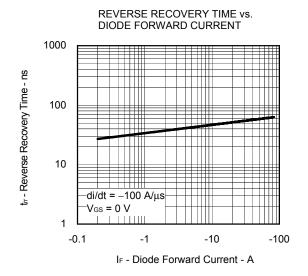






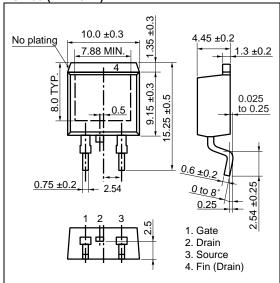




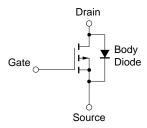


#### PACKAGE DRAWING (Unit: mm)

#### TO-263 (MP-25ZP)



#### **EQUIVALENT CIRCUIT**



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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